November 15, 2007



## **DS10CP152**

## 1.5 Gbps 2X2 LVDS Crosspoint Switch

### **General Description**

The DS10CP152 is a 1.5 Gbps 2x2 LVDS crosspoint switch optimized for high-speed signal routing and switching over lossy FR-4 printed circuit board backplanes and balanced cables. Fully differential signal paths ensure exceptional signal integrity and noise immunity. The non-blocking architecture allows connections of any input to any output or outputs.

Wide input common mode range allows the switch to accept signals with LVDS, CML and LVPECL levels; the output levels are LVDS. A very small package footprint requires a minimal space on the board while the flow-through pinout allows easy board layout. Each differential input and output is internally terminated with a  $100\Omega$  resistor to lower device return losses, reduce component count and further minimize board space.

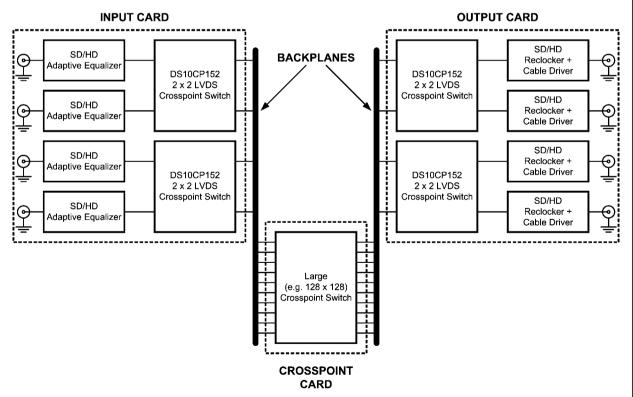
#### **Features**

- DC 1.5 Gbps low jitter, low skew, low power operation
- Pin configurable, fully differential, non-blocking architecture
- Wide Input Common Mode Voltage Range allows DCcoupled interface to LVDS, CML and LVPECL drivers
- On-chip 100Ω input and output termination minimizes insertion and return losses, reduces component count and minimizes board space
- 7 kV ESD on LVDS I/O pins protects adjoining components
- Small SOIC-16 space saving package

### **Applications**

- High-speed channel select applications
- Clock and data buffering and muxing
- SD/HD SDI Routers

## **Typical Application**

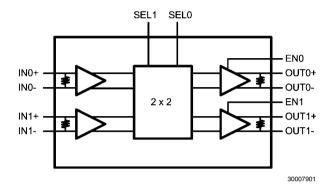


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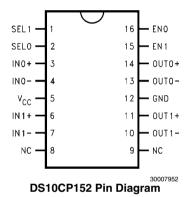
## **Ordering Code**

NSID	Function
DS10CP152TMA	2x2 Crosspoint Switch

## **Block Diagram**



## **Connection Diagram**



## **Pin Descriptions**

Pin Name	Pin	I/O, Type	Pin Description
	Number		
IN0+, IN0- , IN1+, IN1-	3, 4, 6, 7	I, LVDS	Inverting and non-inverting high speed LVDS input pins.
OUT0+, OUT0-, OUT1+, OUT1-	14, 13, 11, 10	O, LVDS	Inverting and non-inverting high speed LVDS output pins.
SEL0, SEL1	1, 2	I, LVCMOS	Switch configuration pins.
EN0, EN1	16, 15	I, LVCMOS	Output enable pins.
NC	8, 9	NC	"NO CONNECT" pins.
VDD	5	Power	Power supply pin.
GND	12	Power	Ground pin.

≥1250V

## **Absolute Maximum Ratings** (Note 4)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

-0.3V to +4V Supply Voltage LVCMOS Input Voltage -0.3V to  $(V_{CC} + 0.3V)$ LVDS Input Voltage -0.3V to +4VLVDS Differential Input Voltage 0V to 1V LVDS Output Voltage -0.3V to  $(V_{CC} + 0.3V)$ LVDS Differential Output Voltage 0V to 1V LVDS Output Short Circuit Current 5 ms Duration +150°C Junction Temperature Storage Temperature Range -65°C to +150°C Lead Temperature Range +260°C Soldering (4 sec.) Maximum Package Power Dissipation at 25°C

Package Thermal Resistance	
$\theta_{JA}$	+72.7°C/W
$\theta_{JC}$	+41.2°C/W
ESD Susceptibility	
HBM (Note 1)	≥7 kV
MM (Note 2)	≥250V

Note 1: Human Body Model, applicable std. JESD22-A114C
Note 2: Machine Model, applicable std. JESD22-A115-A
Note 3: Field Induced Charge Device Model, applicable std.
JESD22-C101-C

CDM (Note 3)

# Recommended Operating Conditions

	Min	Тур	Max	Units
Supply Voltage (V <sub>CC</sub> )	3.0	3.3	3.6	V
Receiver Differential Input Voltage $(V_{ID})$	0		1	V
Operating Free Air Temperature (T <sub>A</sub> )	-40	+25	+85	°C

#### **DC Electrical Characteristics**

M16A Package

Derate M16A Package

Over recommended operating supply and temperature ranges unless otherwise specified. (Notes 5, 6, 7)

13.75 mW/°C above +25°C

1.72W

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
LVCMOS DC SPECIFICATIONS							
V <sub>IH</sub>	High Level Input Voltage		2.0		$V_{DD}$	V	
V <sub>IL</sub>	Low Level Input Voltage		GND		0.8	V	
I <sub>IH</sub>	High Level Input Current	V <sub>IN</sub> = 3.6V V <sub>CC</sub> = 3.6V	40	175	250	μA	
I <sub>IL</sub>	Low Level Input Current	V <sub>IN</sub> = GND V <sub>CC</sub> = 3.6V		±1	±10	μA	
V <sub>CL</sub>	Input Clamp Voltage	$I_{CL} = -18 \text{ mA}, V_{CC} = 0V$		-0.9	-1.5	V	
LVDS IN	PUT DC SPECIFICATIONS						
V <sub>ID</sub>	Input Differential Voltage		0		1	V	
V <sub>TH</sub>	Differential Input High Threshold	$V_{CM} = +0.05V \text{ or } V_{CC} -0.05V$		0	+100	mV	
V <sub>TL</sub>	Differential Input Low Threshold		-100	0		mV	
V <sub>CMR</sub>	Common Mode Voltage Range	V <sub>ID</sub> = 100 mV	0.05		V <sub>CC</sub> - 0.05	V	
I <sub>IN</sub>	Input Current	V <sub>IN</sub> = 3.6V or 0V V <sub>CC</sub> = 3.6V or 0V		±1	±10	μA	
C <sub>IN</sub>	Input Capacitance	Any LVDS Input Pin to GND		1.7		pF	
R <sub>IN</sub>	Input Termination Resistor	Between IN+ and IN-		100		Ω	

Symbol	Parameter	Conditions	Min	Тур	Max	Units
	LVDS OUTPUT DC SPECIFICATIONS					
V <sub>OD</sub>	Differential Output Voltage		250	350	450	mV
ΔV <sub>OD</sub>	Change in Magnitude of V <sub>OD</sub> for Complimentary Output States	$R_L = 100\Omega$	-35		35	mV
V <sub>os</sub>	Offset Voltage		1.05	1.2	1.375	V
ΔV <sub>OS</sub>	Change in Magnitude of V <sub>OS</sub> for Complimentary Output States	$R_L = 100\Omega$	-35		35	mV
I <sub>os</sub>	Output Short Circuit Current (Note 8)	OUT to GND		-23	-55	mA
		OUT to V <sub>CC</sub>		8	55	mA
C <sub>OUT</sub>	Output Capacitance	Any LVDS Output Pin to GND		1.2		pF
R <sub>OUT</sub>	Output Termination Resistor	Between OUT+ and OUT-		100		Ω
SUPPLY	CURRENT	·		•		
I <sub>CC</sub>	Supply Current	EN0 = EN1 = H		58	70	mA
I <sub>CCZ</sub>	Outputs Powered Down Supply Current	EN0 = EN1 = L		25	30	mA

Note 4: "Absolute Maximum Ratings" indicate limits beyond which damage to the device may occur, including inoperability and degradation of device reliability and/or performance. Functional operation of the device and/or non-degradation at the Absolute Maximum Ratings or other conditions beyond those indicated in the Recommended Operating Conditions is not implied. The Recommended Operating Conditions at which the device is functional and the device should not be operated beyond such conditions.

**Note 5:** The Electrical Characteristics tables list guaranteed specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not guaranteed.

Note 6: Current into device pins is defined as positive. Current out of device pins is defined as negative. All voltages are referenced to ground except  $V_{OD}$  and  $\Delta V_{OD}$ .

Note 7: Typical values represent most likely parametric norms for  $V_{CC} = +3.3 \text{V}$  and  $T_A = +25 ^{\circ}\text{C}$ , and at the Recommended Operation Conditions at the time of product characterization and are not guaranteed.

Note 8: Output short circuit current (I<sub>OS</sub>) is specified as magnitude only, minus sign indicates direction only.

#### **AC Electrical Characteristics**

Over recommended operating supply and temperature ranges unless otherwise specified. (Notes 9, 10)

Symbol	Parameter	Cond	litions	Min	Тур	Max	Units
LVDS OUTPU	T AC SPECIFICATIONS	•		•	•		
t <sub>PLHD</sub>	Differential Propagation Delay Low to				440	650	ps
	High (Note 11)	$R_{\rm I} = 100\Omega$	B <sub>1</sub> = 1000				<del>                                     </del>
t <sub>PHLD</sub>	Differential Propagation Delay High to Low (Note 11)				400	650	ps
t <sub>SKD1</sub>	Pulse Skew It <sub>PLHD</sub> – t <sub>PHLD</sub> I (Notes 11, 12)				40	120	ps
t <sub>SKD2</sub>	Channel to Channel Skew (Notes 11, 13)				25	60	ps
t <sub>SKD3</sub>	Part to Part Skew (Notes 11, 14)				45	190	ps
t <sub>LHT</sub>	Rise Time (Note 11)	D 4000			170	350	ps
t <sub>HLT</sub>	Fall Time (Note 11)	$R_L = 100\Omega$			170	350	ps
t <sub>ON</sub>	Output Enable Time				5	20	μs
t <sub>OFF</sub>	Output Disable Time				3	12	ns
t <sub>SEL</sub>	Select Time				3	12	ns
JITTER PERF	ORMANCE (Note 11)			•			
t <sub>RJ1</sub>		V <sub>ID</sub> = 350 mV	135 MHz		0.5	1.2	ps
t <sub>RJ2</sub>	Random Jitter (RMS Value)	$V_{CM} = 1.2V$	311 MHz		0.5	1.2	ps
t <sub>RJ3</sub>		Clock (RZ)	503 MHz		0.5	1.2	ps
t <sub>RJ4</sub>			750 MHz		0.5	1.2	ps
t <sub>DJ1</sub>		$V_{ID} = 350 \text{ mV}$	270 Mbps		9	38	ps
t <sub>DJ2</sub>	Deterministic Jitter	$V_{CM} = 1.2V$	622 Mbps		7	36	ps
t <sub>DJ3</sub>	(Peak-to-Peak Value )	Clock (RZ)	1.06 Gbps		7	34	ps
t <sub>DJ4</sub>			1.5 Gbps		9	35	ps
t <sub>TJ1</sub>		V <sub>ID</sub> = 350 mV	270 Mbps		0.01	0.03	UI <sub>P-P</sub>
t <sub>TJ2</sub>	Total Jitter (Peak to Peak Value)	V <sub>CM</sub> = 1.2V	622 Mbps		0.01	0.04	UI <sub>P-P</sub>
t <sub>TJ3</sub>	Total officer (Feak to Feak Value)	PRBS-23 (NRZ)	1.06 Gbps		0.01	0.05	UI <sub>P-P</sub>
t <sub>TJ4</sub>			1.5 Gbps		0.01	0.07	UI <sub>P-P</sub>

**Note 9:** The Electrical Characteristics tables list guaranteed specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not guaranteed.

Note 10: Typical values represent most likely parametric norms for  $V_{CC} = +3.3 \text{V}$  and  $T_A = +25 ^{\circ}\text{C}$ , and at the Recommended Operation Conditions at the time of product characterization and are not guaranteed.

Note 11: Specification is guaranteed by characterization and is not tested in production.

Note 12: t<sub>SKD1</sub>, lt<sub>PLHD</sub> – t<sub>PHLD</sub>I, Pulse Skew, is the magnitude difference in differential propagation delay time between the positive going edge and the negative going edge of the same channel.

Note 13:  $t_{SKD2^+}$  Channel to Channel Skew, is the difference in propagation delay  $(t_{PLHD} \text{ or } t_{PHLD})$  among all output channels in Broadcast mode (any one input to all outputs).

Note 14: t<sub>SKD3</sub>, Part to Part Skew, is defined as the difference between the minimum and maximum differential propagation delays. This specification applies to devices at the same V<sub>CC</sub> and within 5°C of each other within the operating temperature range.

Note 15: Measured on a clock edge with a histogram and an acummulation of 1500 histogram hits. Input stimulus jitter is subtracted geometrically.

Note 16: Tested with a combination of the 1100000101 (K28.5+ character) and 0011111010 (K28.5- character) patterns. Input stimulus jitter is subtracted algebraically.

Note 17: Measured on an eye diagram with a histogram and an acummulation of 3500 histogram hits. Input stimulus jitter is subtracted.

## **DC Test Circuits**

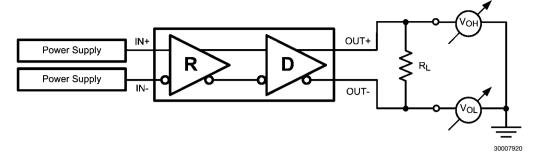
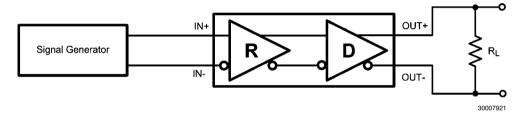


FIGURE 1. Differential Driver DC Test Circuit

## **AC Test Circuits and Timing Diagrams**



**FIGURE 2. Differential Driver AC Test Circuit** 

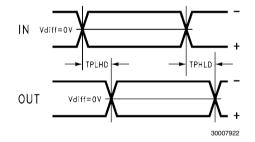


FIGURE 3. Propagation Delay Timing Diagram

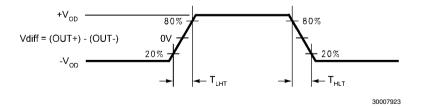


FIGURE 4. LVDS Output Transition Times

Functional Description
The DS10CP152 is a 1.5 Gbps 2x2 LVDS digital crosspoint switch optimized for high-speed signal routing and switching

over lossy FR-4 printed circuit board backplanes and balanced cables.

#### **TABLE 1. Switch Configuration Truth Table**

SEL1	SEL0	OUT1	OUT0
0	0	IN0	INO
0	1	IN0	IN1
1	0	IN1	IN0
1	1	IN1	IN1

#### **TABLE 2. Output Enable Truth Table**

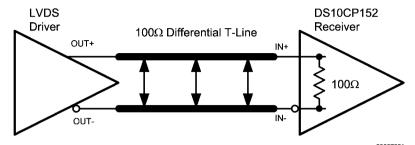
EN1	EN0	OUT1	OUT0
0	0	Disabled	Disabled
0	1	Disabled	Enabled
1	0	Enabled	Disabled
1	1	Enabled	Enabled

#### INPUT INTERFACING

The DS10CP152 accepts differential signals and allows simple AC or DC coupling. With a wide common mode range, the DS10CP152 can be DC-coupled with all common differential

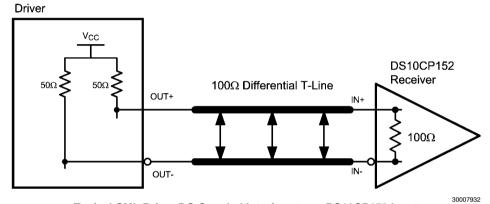
drivers (i.e. LVPECL, LVDS, CML). The following three figures illustrate typical DC-coupled interface to common differential drivers. Note that the DS10CP152 inputs are internally terminated with a  $100\Omega$  resistor.

30007933



Typical LVDS Driver DC-Coupled Interface to an DS10CP152 Input

CML3.3V or CML2.5V



Typical CML Driver DC-Coupled Interface to an DS10CP152 Input

LVPECL Driver  $100\Omega$  Differential T-Line  $100\Omega$  Differential T-Line  $100\Omega$ 

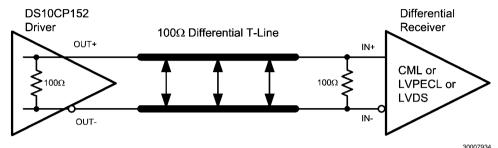
Typical LVPECL Driver DC-Coupled Interface to an DS10CP152 Input

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#### **OUTPUT INTERFACING**

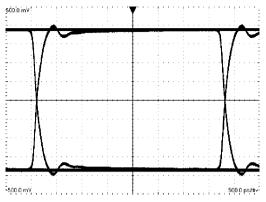
The DS10CP152 outputs signals compliant to the LVDS standard. Its outputs can be DC-coupled to most common differential receivers. The following figure illustrates typical DC-coupled interface to common differential receivers and

assumes that the receivers have high impedance inputs. While most differential receivers have a common mode input range that can accomodate LVDS compliant signals, it is recommended to check respective receiver's data sheet prior to implementing the suggested interface implementation.

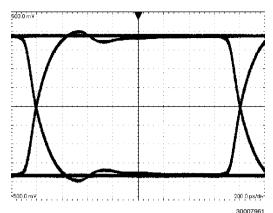


Typical DS10CP152 Output DC-Coupled Interface to an LVDS, CML or LVPECL Receiver

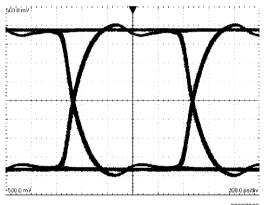
## **Typical Performance Characteristics**



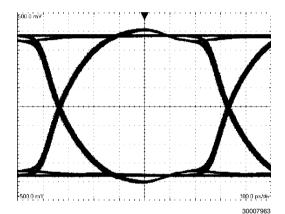
A 270 Mbps NRZ PRBS-7 After 2"
Differential FR-4 Stripline
V:100 mV / DIV, H:500 ps / DIV



A 622 Mbps NRZ PRBS-7 After 2" Differential FR-4 Stripline V:100 mV / DIV, H:200 ps / DIV

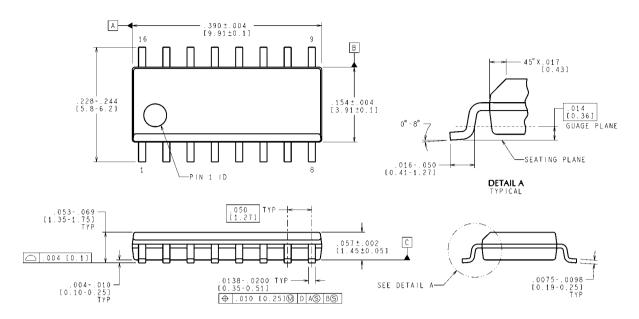


A 1.06 Gbps NRZ PRBS-7 After 2" Differential FR-4 Stripline V:100 mV / DIV, H:200 ps / DIV



A 1.5 Gbps NRZ PRBS-7 After 2" Differential FR-4 Stripline V:100 mV / DIV, H:100 ps / DIV

## Physical Dimensions inches (millimeters) unless otherwise noted



CONTROLLING DIMENSION IS INCH VALUES IN [ ] ARE MILLIMETERS

M16A (Rev J)

Order Number DS10CP152TMA NS Package Number M16A

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### **Notes**

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